Main Switch Power MOSFET and Dual Charging BJT

-12 V, -6.2 A, μCool™ Single P-Channel with Dual PNP low V_{ce(sat)} Transistors, 3x3 mm WDFN Package

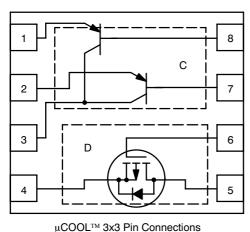
This device integrates one high performance power MOSFET and two low $V_{ce(sat)}$ transistors, greatly reducing the layout space and optimizing charging performance in the battery-powered portable electronics.

Features

- High Performance Power MOSFET
- Dual-Low V_{ce(sat)} Transistors as Charging Power Mux
- 3.0x3.0x0.8 mm WDFN Package
- Independent Pin-out Provides Circuit Flexibility
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

Applications

- Main Switch and Battery Charging Mux for Portable Electronics
- Optimized for Commercial PMUs from Top Suppliers (See Figure 2)



(Top View)

Figure 1. Simple Schematic



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MOSFET

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-12 V	32 mΩ @ -4.5 V	-6.2 A
-12 V	44 mΩ @ -2.5 V	-0.2 A

Low V_{ce(sat)} PNP (Wall)

V _{CEO} MAX	V _{EBO} MAX	I _C MAX
-30 V	-8.0 V	-2.0 A

Low V_{ce(sat)} PNP (USB)

V _{CEO} MAX	V _{EBO} MAX	I _C MAX
-30 V	-8.0 V	-2.0 A

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MARKING DIAGRAM



DFN8 CASE 506BC

3116 = Device Code A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NUS3116MTR2G	WDFN8 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

P-Channel Power MOSFET Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units		
Drain-to-Source Voltage	V _{DSS}	-12	V		
Gate-to-Source Voltage				±8.0	V
Continuous Drain Current (Note 1)	Steady State	T _A = 25°C	I _D	-5.47	Α
		T _A = 85°C		-4.0	
	t ≤ 5 s	T _A = 25°C		-6.2	
Power Dissipation (Note 1)	Steady State	T 0500	P_{D}	1.7	W
	$T_{A} = 25^{\circ}C$			2.2	
Continuous Drain Current (Note 2, Minimum Pad)	Steady State	T _A = 25°C	I _D	-4.4	Α
		T _A = 85°C		-3.2	
Power Dissipation (Note 2)		T _A = 25°C	P_{D}	1.14	W
Pulsed Drain Current	I _{DM}	-25	Α		
Operating Junction and Storage Temperature				-55 to 150	°C
Source Current (Body Diode) ²				-2.8	Α
Lead Temperature for Soldering Purposes (1/8" from car	se for 10 s)		TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	110	°C/W
Junction-to-Ambient – t < 10 s (Note 2)	$R_{\theta JA}$	56	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	72	°C/W
Junction-to-Ambient – t < 10 s (Note 1)	$R_{\theta JA}$	40	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size of 0.5 in sq, 1 oz. Cu.

P-Channel MOSFET Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS	OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I	_D = -250 μA	-12.0			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = -250 μA, ref to 25°C			-10.1		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$,	$T_J = 25^{\circ}C$			-1.0	μΑ
		$V_{DS} = -12 V$	T _J = 125°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$				±200	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$,	I _D = -250 μA	-0.45	-0.67	-1.1	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.68		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$			32	40	mΩ
		V _{GS} = -2.5 \	V, I _D = -3.0 A		44	50	
Forward Transconductance	9FS	V _{DS} = -16 \	/, I _D = -3.0 A		5.9		S

3. Pulsed Condition: Pulse Width = 300 $\mu sec,$ Duty Cycle $\leq 2\%$

P-Channel MOSFET Electrical Characteristics (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
CHARGES, CAPACITANCES AND GAT	TE RESISTANCE	•					•
Input Capacitance	C _{ISS}		f = 1.0 MHz,		1329		pF
Output Capacitance	C _{OSS}	$V_{DS} =$	-12 V		200		
Reverse Transfer Capacitance	C _{RSS}				116		
Total Gate Charge	Q _{G(tot)}	$V_{GS} = -4.5 V_{s}$	V _{DS} = -12 V, -3.0 A		13		nC
Threshold Gate Charge	Q _{G(th)}	ID = -	·3.0 A		1.5		
Gate-to-Source Charge	Q_{GS}				2.2		
Gate-to-Drain Charge	Q_{GD}				2.9		1
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t _{d(on)}	$V_{GS} = -4.5 \text{ V}$	V _{DD} = -12 V, A, R _G = 3.0		8		ns
Rise Time	t _r	I _D = -3.0 F	$A, H_G = 3.0$		17.5		
Turn-Off Delay Time	t _{d(off)}				80		
Fall Time	t _f				56.5		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Recovery Voltage	V_{SD}	$V_{GS} = 0 V$,	T _J = 25°C		-0.66	-1.2	V
		I _S = -1.0 A	T _J = 125°C		-0.54		
Reverse Recovery Time	t _{rr}	$V_{GS} = 0 \text{ V},$ $dISD/dt = 100 \text{ A/}\mu\text{s},$ $I_{S} = -1.0 \text{ A}$			70.8		ns
Charge Time	t _a				14.3		
Discharge Time	t _b	1		56.4			
Reverse Recovery Charge	Q_{RR}	1		44		nC	

^{3.} Pulsed Condition: Pulse Width = 300 $\mu sec,$ Duty Cycle $\leq 2\%$

Dual-PNP Transistors Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units	
Collector-Emitter Voltage	V _{CEO}	-30	V	
Collector-Base Voltage	V_{CBO}	-30	V	
Emitter-Base Voltage	V_{EBO}	-8.0	V	
Collector Current, Continous	I _C	-2.0	Α	
Collector Current, Pulsed (Note 4)	I _C	-6.0	Α	
Operating Junction and Storage Temperature	T_{J} , T_{STG}	-55 to 150	°C	
Thermal Resistance Dissipation	P_{D}	1.5	W	
Thermal Resistance (Note 5)	$R_{ hetaJA}$	83	°C/W	
Thermal Resistance Dissipation	P _D	810	mW	
Thermal Resistance (Note 6)	$R_{ hetaJA}$	155	°C/W	

Single Pulse: Pulse Width = 1 ms
 Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
 Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm², 1 oz. Cu.

Dual-PNP Transistors Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter Symbol		Test Condition	Min	Тур	Max	Units
OFF CHARACTERISTICS						
Collector-Emitter Voltage	V_{CEO}	$I_{C} = -10 \text{ mA}, I_{B} = 0$	-30			V
Collector-Base Voltage	V _{CBO}	I _C = -0.1 mA, I _E = 0	-30			V
Emitter-Base Voltage	V _{EBO}	I _E = -0.1 mA, I _C = 0	-8.0			V
Collector-Emitter Cutoff Current	I _{CES}	V _{CES} = -30 V			-0.1	μΑ
ON CHARACTERISTICS						
DC Current Gain (Note 7)	h _{FE}	I _C = -1.0 A, V _{CE} = -2.0 V	100	200		-
DC Current Gain (Note 7)	h _{FE}	I _C = -2.0 A, V _{CE} = -2.0 V	100	200		-
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -1.0 A, I _B = -0.01 A			0.22	V
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -1.0 A, I _B = -0.1 A			0.12	V
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = -2.0 A, I _B = -0.2 A			0.24	V
Input Capacitance	C _{ibo}	V _{EB} = -0.5 V, f = 1.0 MHz		240	400	pF
Output Capacitance	C _{obo}	V _{CB} = -3.0 V, f = 1.0 MHz		50	100	pF

^{7.} Pulsed Condition: Pulse Width = 300 μsec, Duty Cycle ≤ 2%

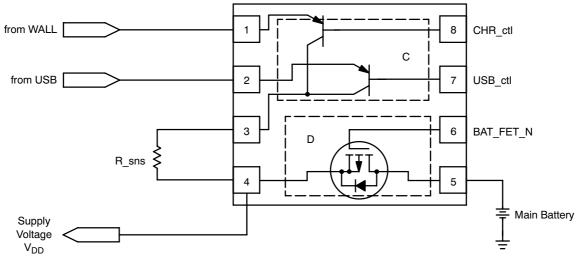


Figure 2. Typical Application Circuit

TYPICAL CHARACTERISTICS - MOSFET

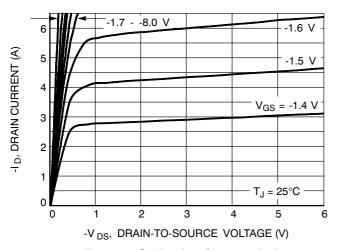


Figure 3. On-Region Characteristics

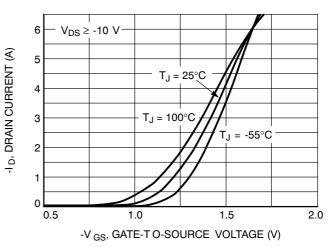


Figure 4. Transfer Characteristics

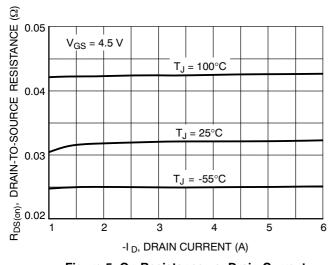


Figure 5. On-Resistance vs. Drain Current

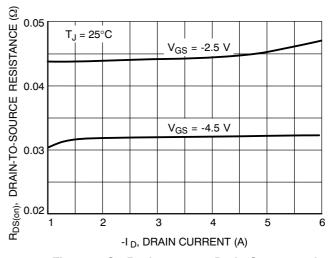


Figure 6. On-Resistance vs. Drain Current and Gate Voltage

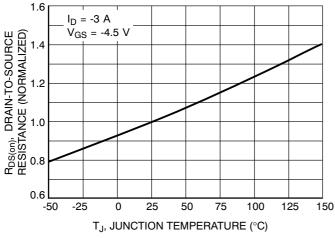


Figure 7. On-Resistance Variation with Temperature

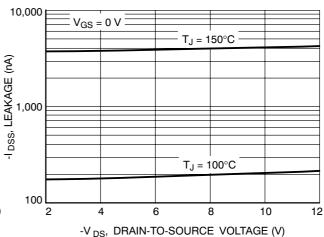


Figure 8. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS - MOSFET

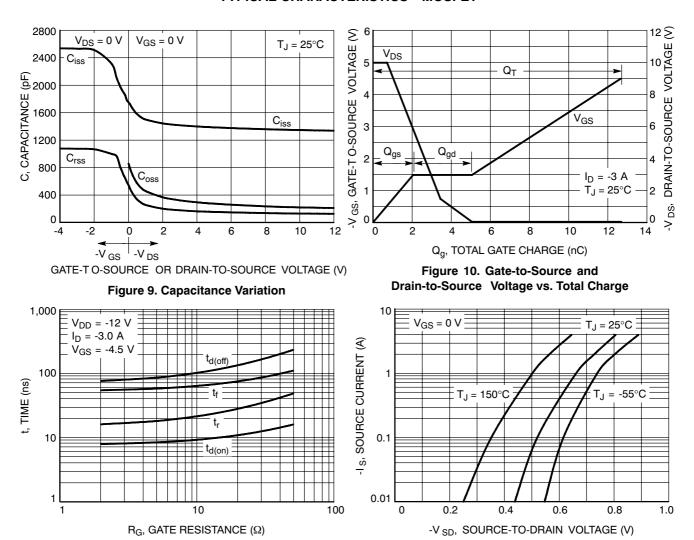


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

Figure 12. Diode Forward Voltage vs. Current

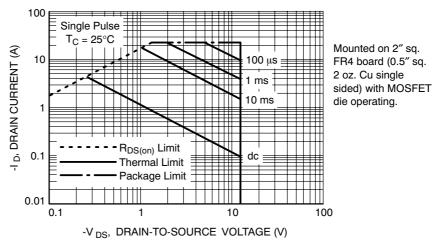


Figure 13. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS - MOSFET

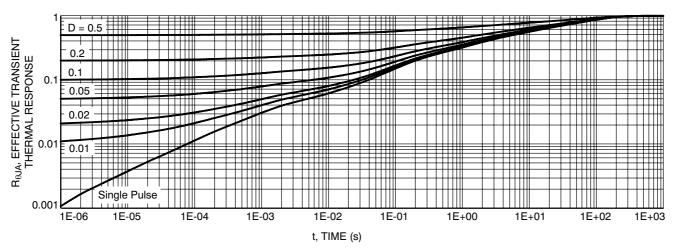


Figure 14. FET Thermal Response

TYPICAL CHARACTERISTICS - BJT

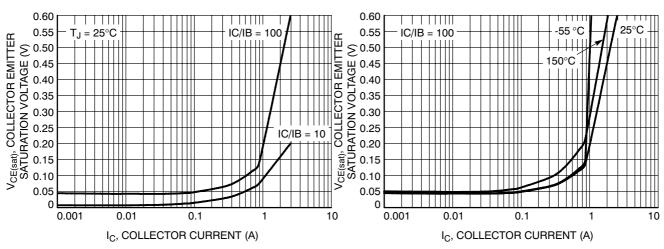


Figure 15. Collector Emitter Saturation Voltage vs. Collector Current

Figure 16. Collector Emitter Saturation Voltage vs. Collector Current

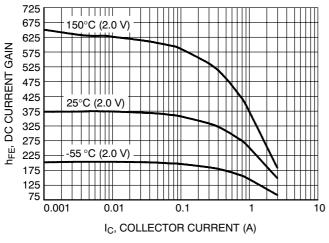


Figure 17. DC Current Gain vs. Collector Current

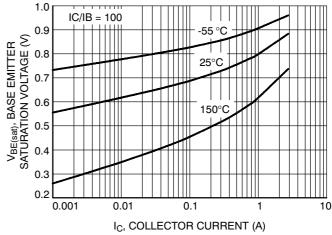


Figure 18. Base Emitter Saturation Voltage vs.
Collector Current

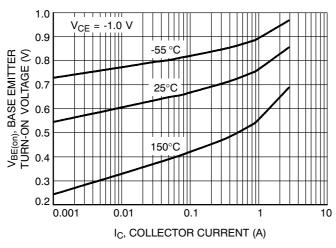


Figure 19. Base Emitter Turn-On Voltage vs.
Collector Current

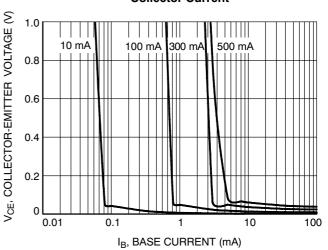
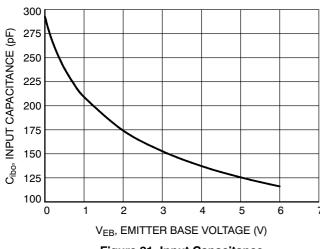
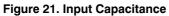


Figure 20. Saturation Region

TYPICAL CHARACTERISTICS - BJT





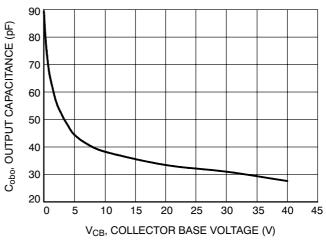
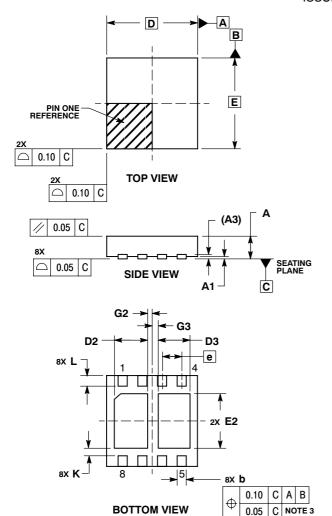


Figure 22. Output Capacitance

PACKAGE DIMENSIONS

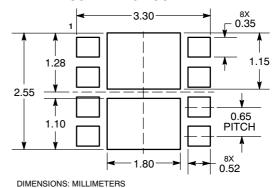
DFN8, 3x3, 0.65P CASE 506BC-01 **ISSUE O**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIM	ETERS	
DIM	MIN	MAX	
Α	0.70	0.80	
A1	0.00	0.05	
A3	0.20	REF	
b	0.25	0.35	
D	3.00	BSC	
D2	1.00	1.20	
D3	0.95	1.15	STYLE 1:
E	3.00	BSC	PIN 1. EMITTER1
E2	1.70	1.90	2. EMITTER2
е	0.65	BSC	3. COLLECTOR
G2	0.15	REF	4. SOURCE
G3	0.20	REF	5. DRAIN 6. GATE
Κ	0.20		7. BASE2
L	0.25	0.45	8. BASE1

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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